

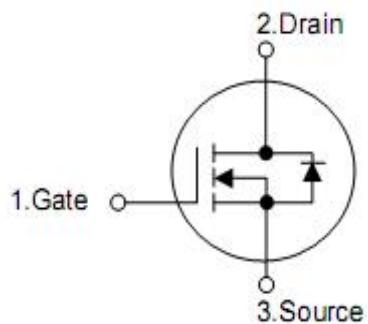
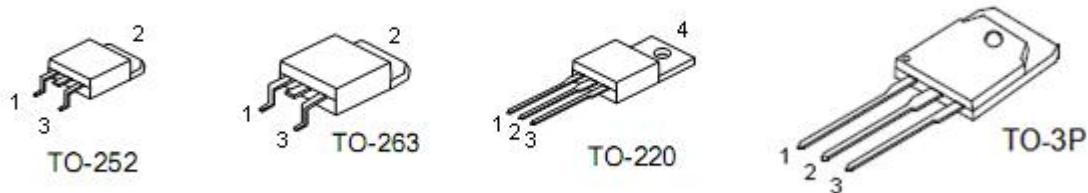
## 1. General Features

- Proprietary New Trench Technology
- $R_{DS(ON),typ.}=6.5\text{m}\Omega$  @  $V_{GS}=10\text{V}$
- Low Gate Charge Minimize Switching Loss
- Fast Recovery Body Diode

## 2. Applications

- High efficiency DC/DC converters
- Synchronous Rectification
- UPS Inverter

## 3. Pin configuration



Pin	Function
1	Gate
2	Drain
3	Source
4	Drain

## 4. Ordering Information

Part Number	Package	Brand
KND3208A	TO-252	KIA
KNB3208A	TO-263	KIA
KNP3208A	TO-220	KIA
KNH3208A	TO-3P	KIA

## 5. Absolute maximum ratings

(T<sub>c</sub>= 25 °C , unless otherwise specified)

Symbol	Parameter	Rating			Unit
		TO-252	TO-263/220	TO-3P	
V <sub>DSS</sub>	Drain-to-Source Voltage <sup>[1]</sup>	85			V
V <sub>GSS</sub>	Gate-to-Source Voltage	±20			
I <sub>D</sub>	Continuous Drain Current <sup>[2]</sup>	100*	100	100	A
	Continuous Drain Current@T <sub>C</sub> =100 °C <sup>[3]</sup>	70*	70	70	
I <sub>DM</sub>	Pulsed Drain Current at V <sub>GS</sub> =10V <sup>[2,4]</sup>	400*	400	400	
E <sub>AS</sub>	Single Pulse Avalanche Energy(L=1mH)	612			mJ
dv /dt	Peak Diode Recovery dv/dt <sup>[3]</sup>	5.0			V/ns
P <sub>D</sub>	Power Dissipation	65	189	224	W
	Derating Factor above 25 °C	0.43	1.3	1.49	W/ °C
T <sub>L</sub> T <sub>PAK</sub>	Maximum Temperature for Soldering Leads at 0.063in (1.6mm) from Case for 10 seconds, Package Body for 10 seconds	300	260		°C
T <sub>J</sub> &T <sub>STG</sub>	Operating and Storage Temperature Range	-55 to 175			

*Caution: Stresses greater than those listed in the "Absolute Maximum Ratings" may cause permanent damage to the device.*

\* Drain current limited by maximum junction temperature.

## 6. Thermal characteristics

Symbol	Parameter	Rating			Unit
		TO-252	TO-263/220	TO-3P	
R <sub>θJC</sub>	Thermal Resistance, Junction-to-Case	2.3	0.79	0.67	°C /W
R <sub>θJA</sub>	Thermal Resistance, Junction-to-Ambient	95	62	52	

## 6. Electrical characteristics

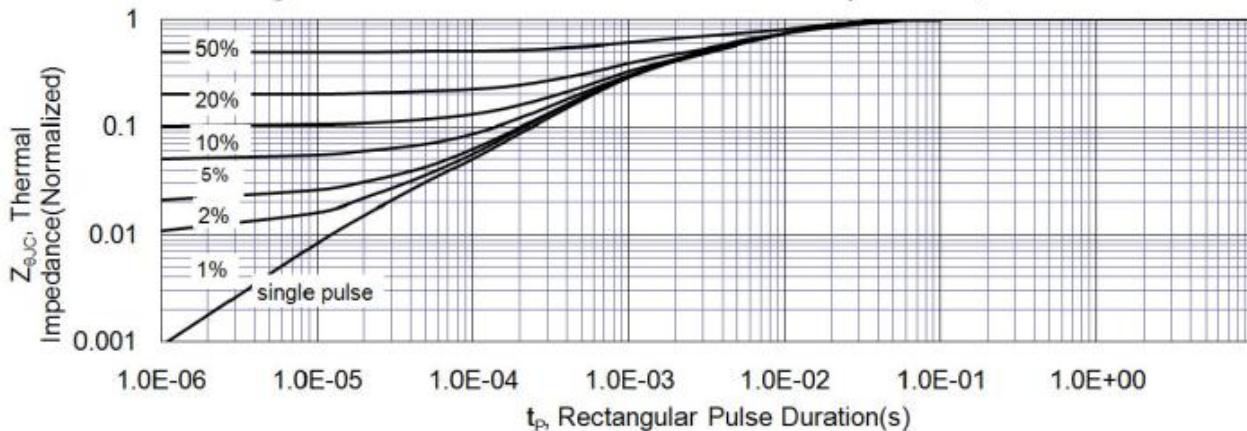
OFF Characteristics		(TJ=25°C,unless otherwise specified)				
Symbol	Parameter	Test Conditions	Min.	Typ.	Max.	Unit
BV <sub>DSS</sub>	Drain-to-Source Breakdown Voltage	V <sub>GS</sub> =0V, I <sub>D</sub> =250uA	85	--	--	V
I <sub>DSS</sub>	Drain-to-Source Leakage Current	V <sub>DS</sub> =80V, V <sub>GS</sub> =0V	--	--	1	uA
		V <sub>DS</sub> =64V, V <sub>GS</sub> =0V, T <sub>J</sub> =125°C	--	--	100	
I <sub>GSS</sub>	Gate-to-Source Leakage Current	V <sub>GS</sub> =+20V, V <sub>DS</sub> =0V	--	--	+100	nA
		V <sub>GS</sub> =-20V, V <sub>DS</sub> =0V	--	--	-100	
ON Characteristics		(TJ=25°C,unless otherwise specified)				
Symbol	Parameter	Test Conditions	Min.	Typ.	Max.	Unit
R <sub>DS(ON)</sub>	Static Drain-to-Source On-Resistance	V <sub>GS</sub> =10V, I <sub>D</sub> =24A <sup>[5]</sup>	--	6.5	8.0	mΩ
V <sub>GS(TH)</sub>	Gate Threshold Voltage	V <sub>DS</sub> =V <sub>GS</sub> , I <sub>D</sub> =250uA	2.0	--	4.0	V
Dynamic Characteristics		Essentially independent of operating temperature				
Symbol	Parameter	Test Conditions	Min.	Typ.	Max.	Unit
C <sub>iss</sub>	Input Capacitance	V <sub>GS</sub> =0V, V <sub>DS</sub> =25V, f=1.0MHZ	--	3420	--	pF
C <sub>oss</sub>	Output Capacitance		--	400	--	
C <sub>rss</sub>	Reverse Transfer Capacitance		--	120	--	
R <sub>g</sub>	Gate Series Resistance	f=1.0MHZ	--	2.0	--	Ω
Q <sub>g</sub>	Total Gate Charge	V <sub>DD</sub> =40V, I <sub>D</sub> =80A, V <sub>GS</sub> =0 to 10V	--	61	--	nC
Q <sub>gs</sub>	Gate-to-Source Charge		--	20	--	
Q <sub>gd</sub>	Gate-to-Drain (Miller) Charge		--	18	--	
Resistive Switching Characteristics		Essentially independent of operating temperature				
Symbol	Parameter	Test Conditions	Min.	Typ.	Max.	Unit
t <sub>d(ON)</sub>	Turn-on Delay Time	V <sub>DD</sub> =40V, I <sub>D</sub> =80A, V <sub>GS</sub> = 10V R <sub>G</sub> =2.5Ω	--	22	--	nS
t <sub>rise</sub>	Rise Time		--	24	--	
t <sub>d(OFF)</sub>	Turn-Off Delay Time		--	100	--	
t <sub>fall</sub>	Fall Time		--	32	--	
Source-Drain Body Diode Characteristics		(T <sub>J</sub> =25°C,unless otherwise specified)				
Symbol	Parameter	Test Conditions	Min	Typ.	Max.	Unit
I <sub>SD</sub>	Continuous Source Current <sup>[2]</sup>	Integral PN-diode in MOSFET	--	--	100	A
I <sub>SM</sub>	Pulsed Source Current <sup>[2]</sup>		--	--	400	
V <sub>SD</sub>	Diode Forward Voltage	I <sub>S</sub> =80A, V <sub>GS</sub> =0V	--	--	1.3	V
t <sub>rr</sub>	Reverse recovery time	V <sub>GS</sub> =0V ,I <sub>F</sub> =20A, dI/dt=100A/μs	--	40	--	ns
Q <sub>rr</sub>	Reverse recovery charge		--	80	--	uC

Note:

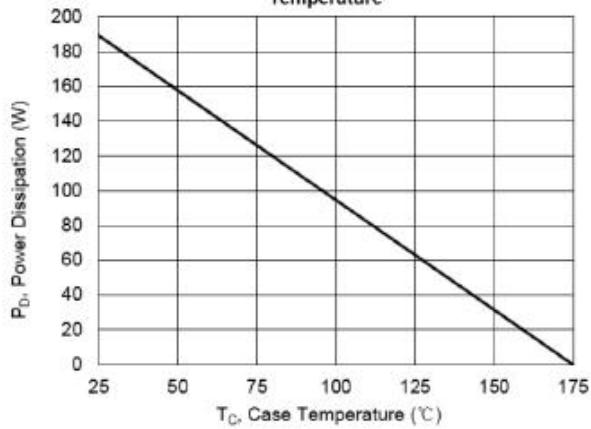
- [1] T<sub>J</sub> =+25 °C to +175 °C.
- [2] Silicon limited current only.
- [3] Package limited current 80A.
- [4] Repetitive rating; pulse width limited by maximum junction temperature.
- [5] Pulse width≤380μs; duty cycle≤2%.

## 7. Test circuits and waveforms

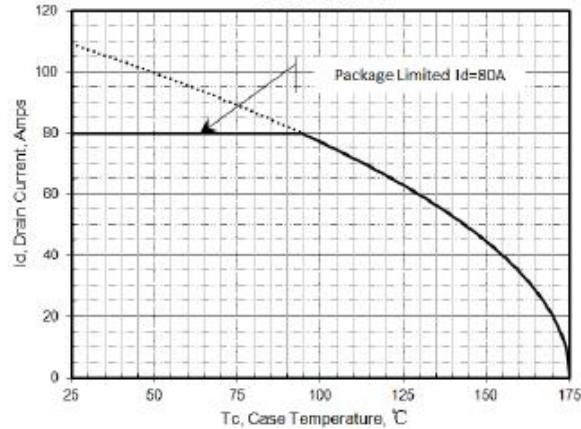
**Figure 1. Maximum Effective Thermal Impedance, Junction-to-Case**



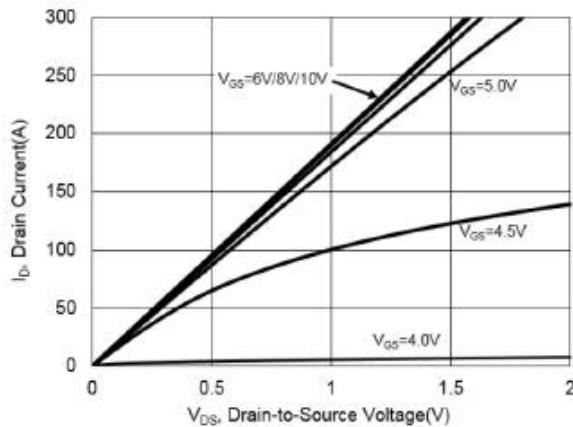
**Figure 2. Maximum Power Dissipation vs. Case Temperature**



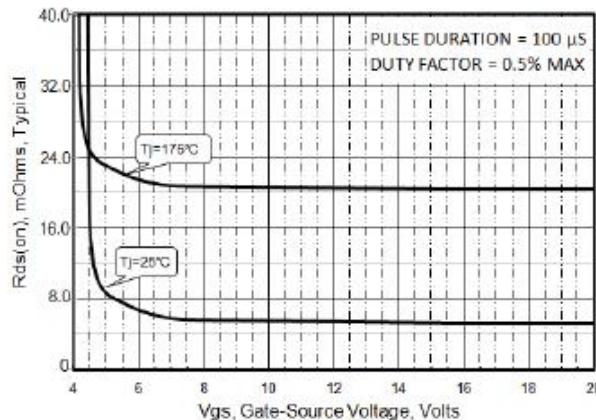
**Figure 3 .Maximum Continuous Drain Current vs Tc**



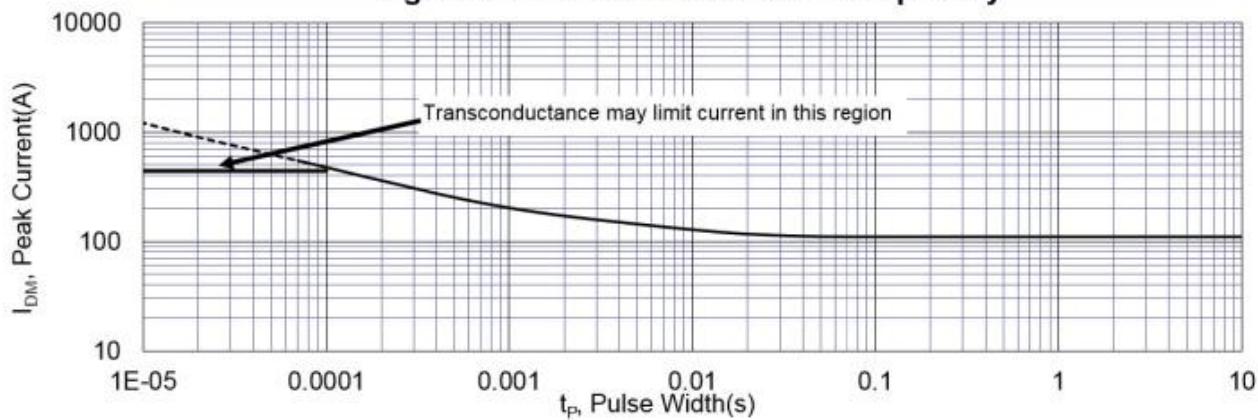
**Figure 4. Typical Output Characteristics**



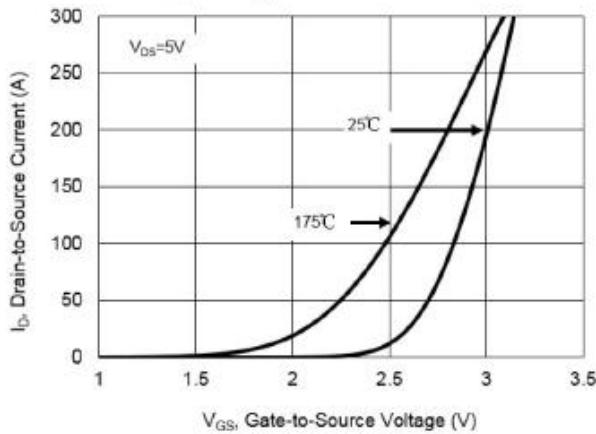
**Figure 5. Rdson vs Gate Voltage**



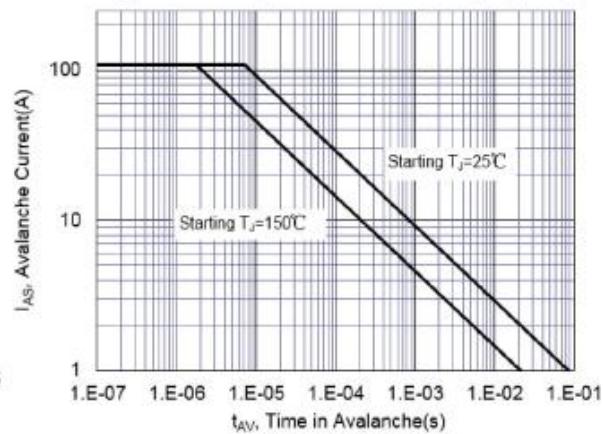
**Figure 6. Maximum Peak Current Capability**



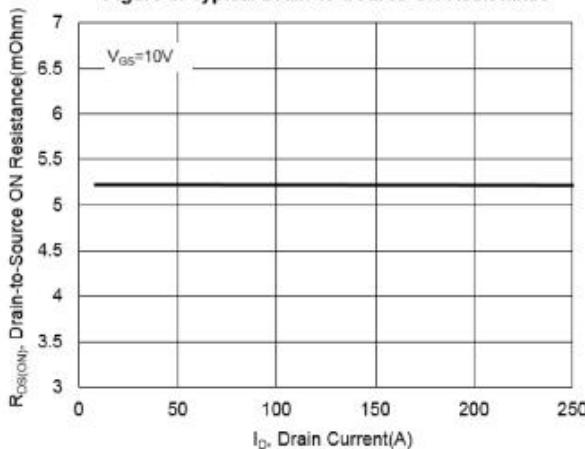
**Figure 7. Typical Transfer Characteristics**



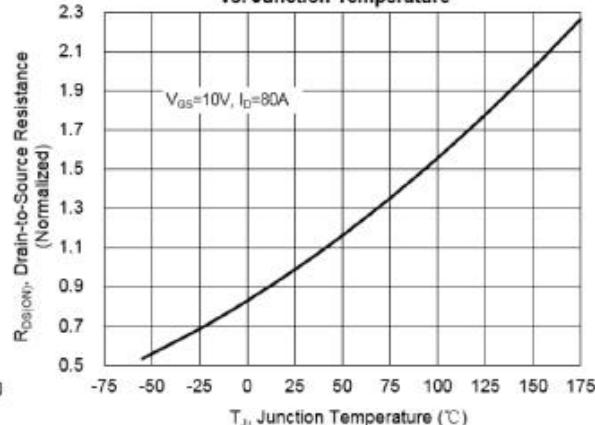
**Figure 8. Unclamped Inductive Switching Capability**

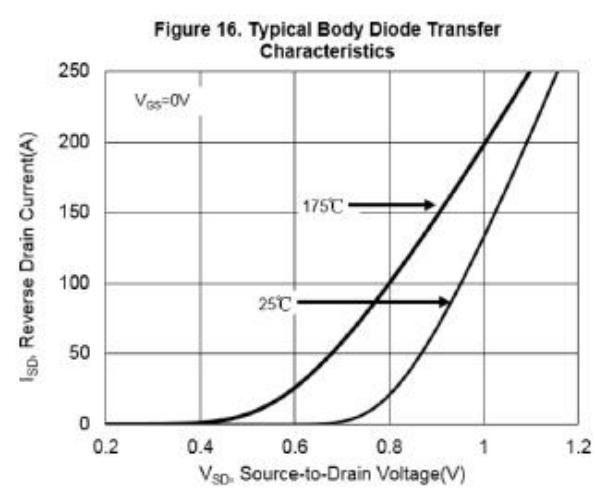
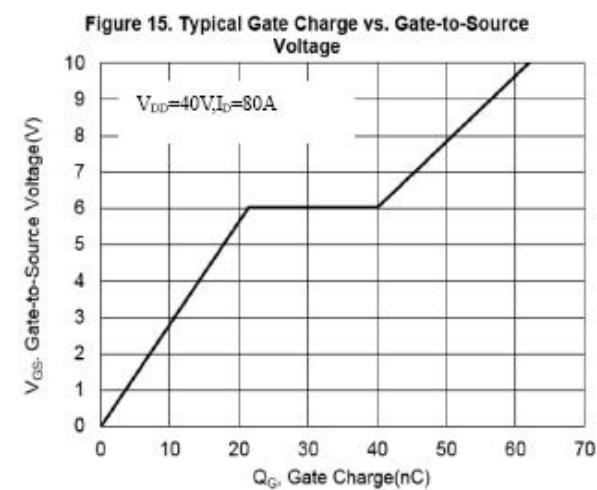
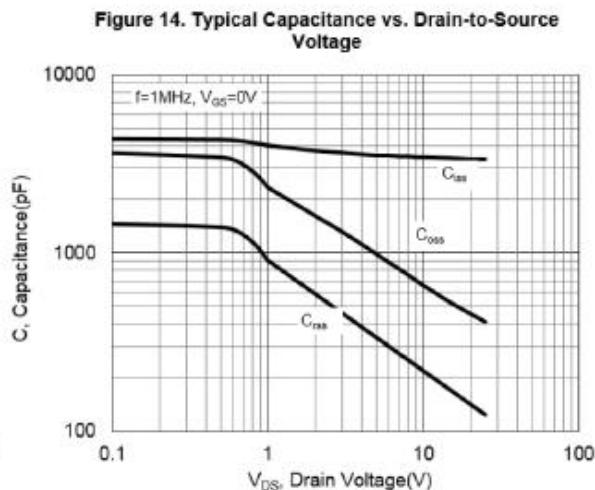
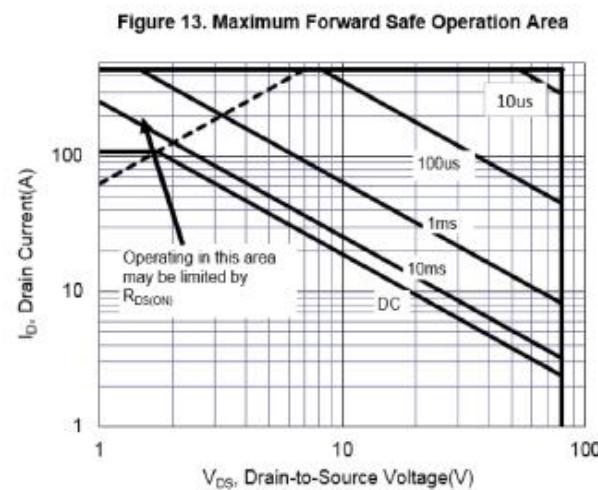
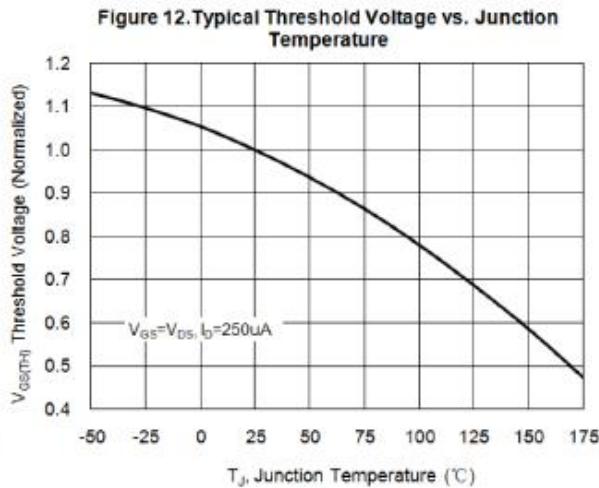
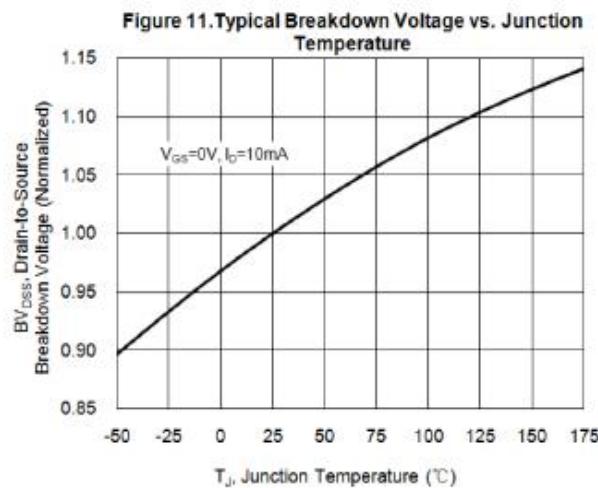


**Figure 9. Typical Drain-to-Source ON Resistance**



**Figure 10. Typical Drain-to-Source On Resistance vs. Junction Temperature**





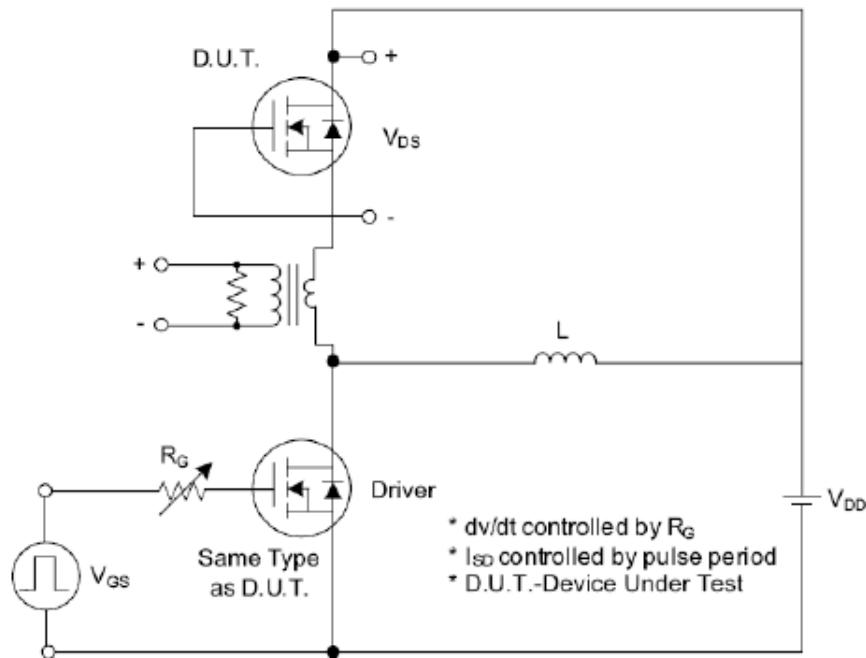


Fig. 1.1 Peak Diode Recovery dv/dt Test Circuit

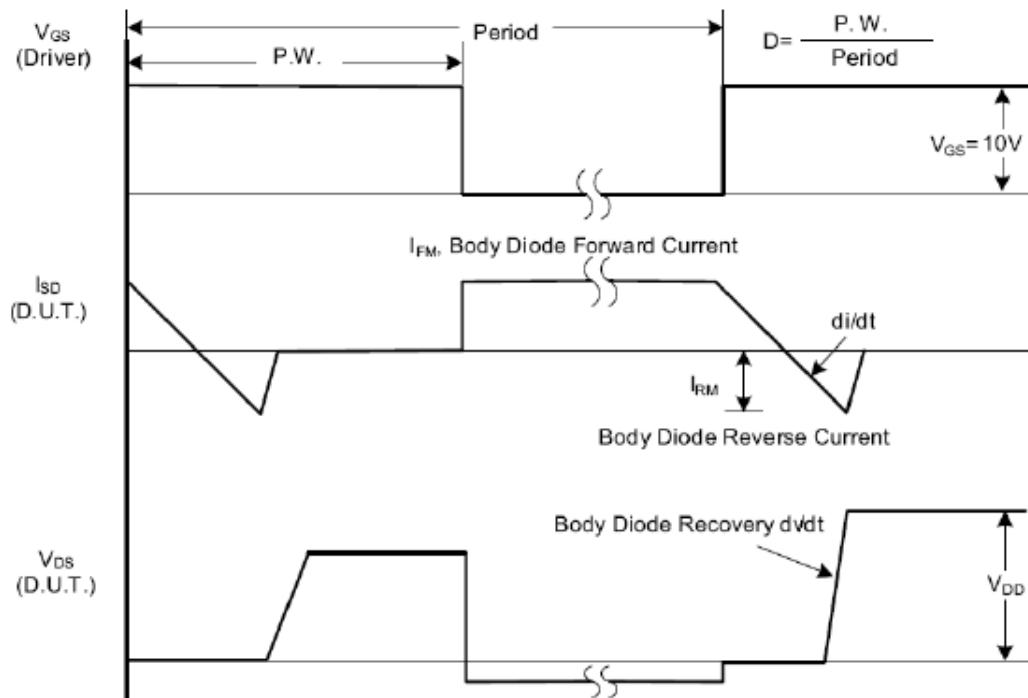


Fig. 1.2 Peak Diode Recovery dv/dt Waveforms

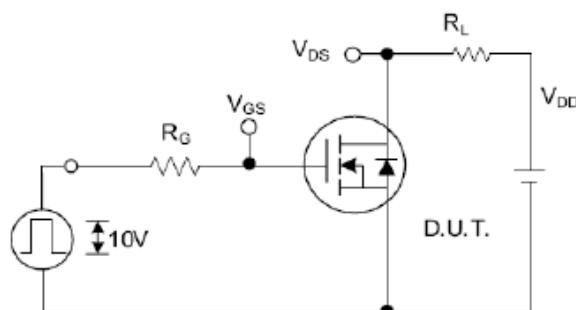


Fig. 2.1 Switching Test Circuit

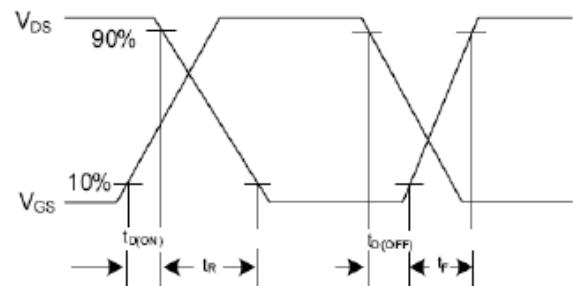


Fig. 2.2 Switching Waveforms

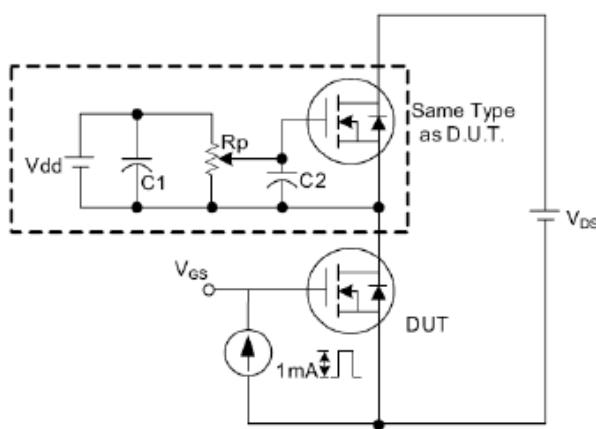


Fig. 3 . 1 Gate Charge Test Circuit

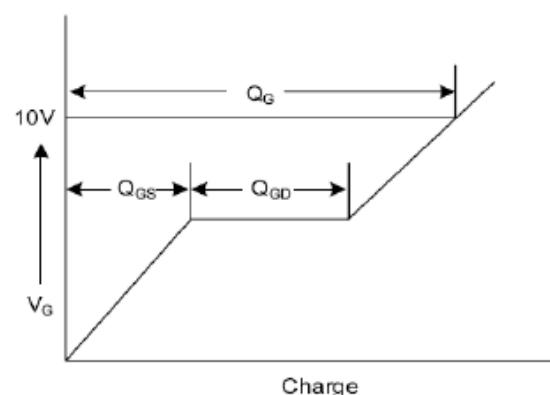


Fig. 3 . 2 Gate Charge Waveform

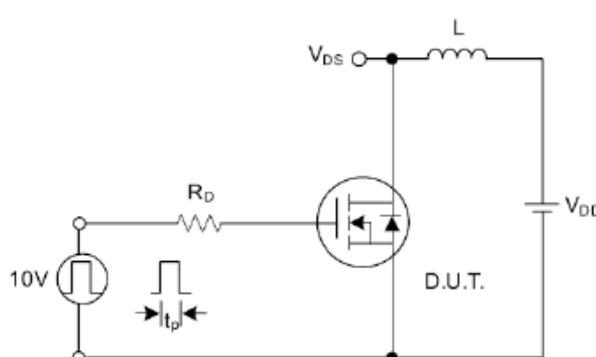


Fig. 4.1 Unclamped Inductive Switching Test Circuit

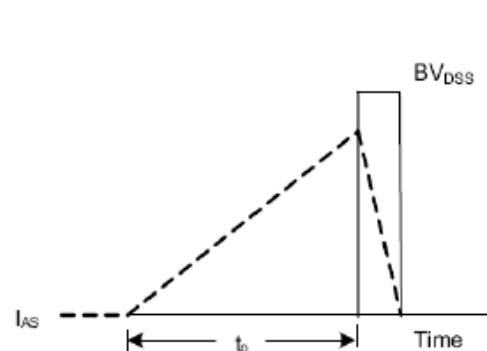


Fig. 4.2 Unclamped Inductive Switching Waveforms

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